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SN54164, SN54LS164, SN74164, SN74LS164 8-BIT PARALLEL-OUT SERIAL SHIFT REGISTERS

MARCH 1974 - REVISED MARCH 1988

- Gated Serial Inputs
- Fully Buffered Clock and Serial Inputs
- Asynchronous Clear

TYPE	MAXIMUM CLOCK FREQUENCY	TYPICAL POWER DISSIPATION
′164	36 MHz	21 mW per bit
'LS164	36 MHz	10 mW per bit

description

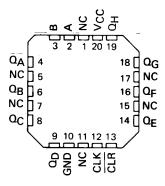
These 8-bit shift registers feature gated serial inputs and an asynchronous clear. The gated serial inputs (A and B) permit complete control over incoming data as a low at either input inhibits entry of the new data and resets the first flip-flop to the low level at the next clock pulse. A high-level input enables the other input which will then determine the state of the first flip-flop. Data at the serial inputs may be changed while the clock is high or low, but only information meeting the setup-time requirements will be entered. Clocking occurs on the low-to-high-level transition of the clock input. All inputs are diode-clamped to minimize transmission-line effects.

The SN54164 and SN54LS164 are characterized for operation over the full military temperature range of $-55\,^{\circ}$ C to 125 $\,^{\circ}$ C. The SN74164 and SN74LS164 are characterized for operation from 0 $\,^{\circ}$ C to 70 $\,^{\circ}$ C.

SN54164, SN54LS164...J OR W PACKAGE SN74164...N PACKAGE SN74LS164...D OR N PACKAGE (TOP VIEW)

ΑC	1	U142 VCC
в□	2	13 QH
$a_A \Box$	3	¹2₽ a G
α _B [4	11 🗖 QF
α _C □	5	10□ α E
$\sigma^{D} \Box$	6	9 <mark>☐ CLR</mark>
GND [7	8 ∏ CLK

SN54LS164 . . . FK PACKAGE (TOP VIEW)



 ${\sf NC}-{\sf No}$ internal connection

FUNCTION TABLE

L	INPUTS	OUTPUTS				
CLEAR	CLOCK	Α	В	α_{A}	αB	Q _H
L	X	Х	Х	L	L	L
Н	L	×	Х	Q _{A0}	o_{B0}	α_{H0}
Н	1	н	Н	Н	Q_{An}	Q_{Gn}
н	1	L	X	L	\mathbf{Q}_{An}	Q_{Gn}
Н	1	Х	L	L	QAn	Q_{Gn}

H = high level (steady state), L = low level (steady state)

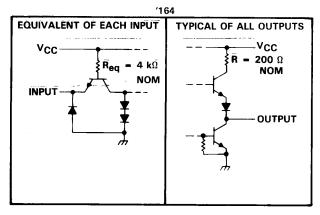
X = irrelevant (any input, including transitions)

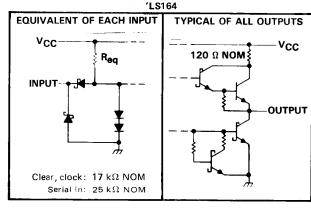
↑ = transition from low to high level.

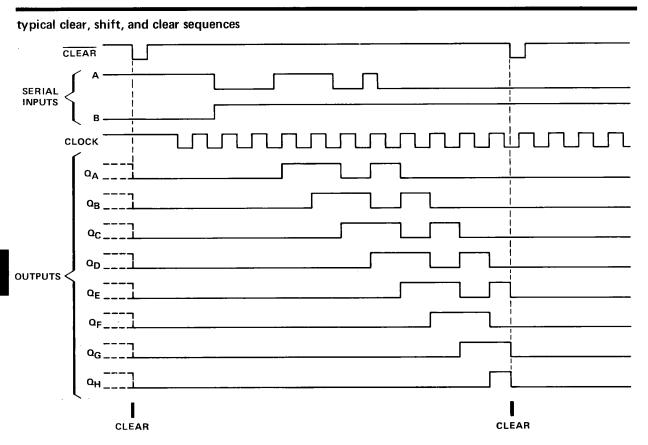
 Ω_{A0} , Ω_{B0} , Ω_{H0} = the level of Ω_{A} , Ω_{B} , or Ω_{H} , respectively, before the indicated steady-state input conditions were established.

 ${\bf Q}_{An},\,{\bf Q}_{Gn}$ = the level of ${\bf Q}_A$ or ${\bf Q}_G$ before the most-recent \uparrow transition of the clock; indicates a one-bit shift.

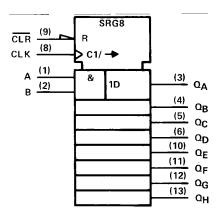
schematics of inputs and outputs





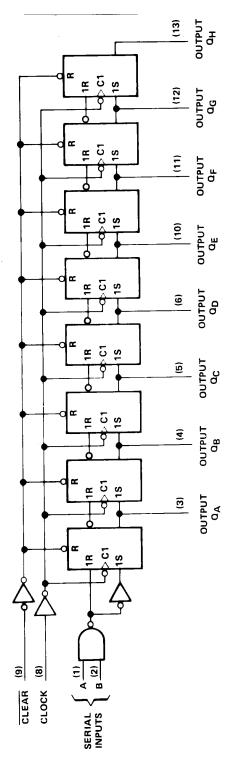


logic symbol†



 $^{^{\}dagger}$ This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, N, and W packages.

logic diagram (positive logic)



Pin numbers shown are for D, J, N, and W packages.

SN54164, SN74164 **8-BIT PARALLEL-OUT SERIAL SHIFT REGISTERS**

absolute maximum ratings over oprating	ng free-air temperature range (unless otherwise noted)
Input voltage	
,	SN74164

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN5416	4		N7416	4	UNIT
	MIN NOM MAX MIN NOM MAX 4.5 5 5.5 4.75 5 5.25 -400 -400 -400 8 8 8 0 25 0 25	UNIT					
Supply voltage, VCC	4.5	5	5.5	4.75	5	5.25	V
High-level output current, IOH			-400			-400	μΑ
Low-level output current, IQL			8	<u> </u>		8	mA
Clock frequency, fclock	0		25	0		25	MHz
Width of clock or clear input pulse, tw	20			20			ns
Data setup time, t _{su} (see Figure 1)	15			15			ns
Data setup time, t _{SU} (Clear Inactive) (see Figure 1)	20			20			ns
Data hold time, th (see Figure 1)	5			5	-		ns
Operating free-air temperature, TA	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER				SN5416	4	SN74164			דומט
		TEST CONDITIONS [†]	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIH	High-level input voltage		2			2			V
VIL	Low-level input voltage				8.0			0.8	\ \ \ \ \
VIK	Input clamp voltage	V _{CC} = MIN, I _I = -12 mA			-1.5			-1.5	V
Voн	High-level output voltage	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OH} = -400 μA	2.4	3.2		2.4	3.2		V
VOL	Low-level output voltage	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OL} = 8 mA		0.2	0.4		0.2	0.4	V
<u> </u>	Input current at maximum input voltage	V _{CC} = MAX, V _I = 5.5 V,			1			1	mA
T _{IH}	High-level input current	V _{CC} = MAX, V ₁ = 2.4 V			40			40	μA
111	Low-level input current	V _{CC} = MAX, V _I = 0.4 V			-1.6			-1.6	mA
los	Short-circuit output current§	V _{CC} = MAX	-10		-27.5	-9		-27.5	mA
ان ا		$V_{CC} = MAX$, $V_{I(clock)} = 0.4 V$		30			30		mA
Icc	Supply current	See Note 2 V _{I(clock)} = 2.4 V	+	37	54		37	54]'''`

[†] For conditions shown at MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: ICC is measured with outputs open, serial inputs grounded, and a momentary ground, then 4.5 V, applied to clear.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ} \text{ C}$

	PARAMETER	TEST CONDIT	IONS	MIN	TYP	MAX	UNIT
f _{max}	Maximum clock frequency		C _L = 15 pF	25	36		MHz
	Propagation delay time, high-to-low-level	1 i	C _L = 15 pF		24	36	ns
^t PHL	Q outputs from clear input	B 500 G	C _L = 50 pF		28	42	1
	Propagation delay time, low-to-high-level	$R_L = 800 \Omega$,	C _{L.} = 15 pF	8	17	27	ns
^t PLH	Q outputs from clock input	See Figure 1	C _L = 50 pF	10	20	30] ""
	Propagation delay time, high-to-low-level		C _L = 15 pF	10	21	32	ns
tPHL		C _L = 50 pF	10	25	37]	



[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C.

[§] Not more than two outputs should be shorted at a time.

SN54LS164, SN74LS164 8-BIT PARALLEL-OUT SERIAL SHIFT REGISTERS

absolute maximum ratings over operating free-air temperature range (unless other	wise noted)
Supply voltage, VCC (see Note 1)	7 V
Input voltage	7 V
Operating free-air temperature range: SN54LS164	-55°C to 125°C
SN74LS164	0°C to 70°C
Storage temperature range	-65°C to 150°C
NOTE 1. Voltage values are with respect to network ground terminal	

recommended operating conditions

		S	SN54LS164		SN74LS164			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
ЮН	High-level output current			- 0.4			- 0.4	mΑ
lOL	Low-level output current			4			8	mA
fclock	Clock frequency	0		25	0		25	MHz
tw	Width of clock or clear input pulse	20			20			ns
t _{su}	Data setup time (See Figure 1)	15			15			ns
t _{su}	Clear inactive setup time (See Figure 1)	20			20		_	ns
th	Data hold time (See Figure 1)	5			5			ns
TA	Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

0.404.45750	TEST CONDITIONS [†]			SN54LS164			S	UNIT			
PARAMETER	15	SI CONDITIONS	o '		MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNII
VIK	V _{CC} = MIN, I	= -18 mA		·			- 1.5			- 1 .5	>
Voн	$V_{CC} = MIN,$ $I_{OH} = -0.4 \text{ mA}$		۷ _{IL}	= MAX,	2.5	3.5		2.7	3.5		٧
	V _{CC} = MIN,	V _{IH} = 2 V,		I _{OL} = 4 mA		0.25	0.4		0.25	0.4	V
VOL	$V_{IL} = MAX$			I _{OL} = 8 mA					0.35	0.5	ľ
l _l	V _{CC} = MAX, \	V _I = 7 V	•		-		0.1			0.1	mA
<u>ин</u>	V _{CC} = MAX,	V _I = 2.7 V				20			20		μΑ
IIL .	V _{CC} = MAX,	V ₁ = 0.4 V					-0.4			-0.4	mA
los	V _{CC} = MAX				- 20		- 100	- 20		- 100	mA
lcc	V _{CC} = MAX, S	See Note 3				16	27		16	27	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{max}	Maximum clock frequency		25	36		MHz
^t PHL	Propagation delay time, high-to-low-level Q outputs from clear input	$R_L = 2 k\Omega$, $C_L = 15 pF$,		24	36	ns
^t PLH	Propagation delay time, low-to-high-level Q outputs from clock input	See Figure 1		17	27	ns
tPHL	Propagation delay time, high-to-low-level Q outputs from clock input	_		21	32	ns



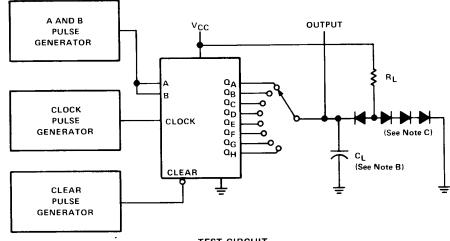
 $^{^{\}ddagger}$ All typical values are at V_{CC} = 5 V, T_A = 25 °C.

⁵Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

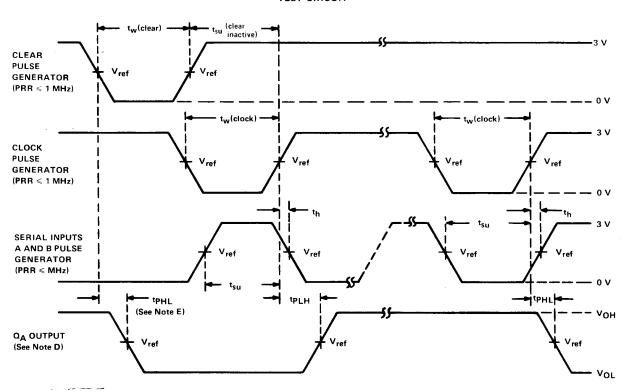
NOTE 3: I_{CC} is measured with outputs open, serial inputs grounded, the clock input at 2.4 V, and a momentary ground, then 4.5 V applied to clear.

SN54164, SN54LS164, SN74164, SN74LS164 **8-BIT PARALLEL-OUT SERIAL SHIFT REGISTERS**

PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT



VOLTAGE WAVEFORMS

- NOTES: A. The pulse generators have the following characteristics: duty cycle \leq 50%, $Z_{out} \approx$ 50 Ω ; for '164, $t_{f} \leq$ 10 ns, $t_{f} \leq$ 10 ns; and for 'LS164, $t_r \le 15 \text{ ns}, t_f \le 6 \text{ ns}.$
 - B. C_L includes probe and jig capacitance.
 - C. All diodes are 1N3064 or equivalent.
 - D. QA output is illustrated. Relationship of serial input A and B data to other Q outputs is illustrated in the typical shift sequence.
 - E. Outputs are set to the high level prior to the measurement of tpHL from the clear input.
 - F. For '164, $V_{ref} = 1.5 \text{ V}$; for 'LS164, $V_{ref} = 1.3 \text{ V}$.

FIGURE 1-SWITCHING TIMES



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